

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10584419	LEE ET AL.
	Examiner	Art Unit
	M. Lee	2622

SEARCHED			
Class	Subclass	Date	Examiner
348	725, 723, 729, 441	1/16/10	ml
375	240.01, 240.26, 240.18,	1/16/10	ml

SEARCH NOTES			
Search Notes	Date	Examiner	
east	1/16/10	ml	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

	/M. Lee/ Primary Examiner.Alt Unit 2622
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